## Applicant(s)/Patent Under Application/Control No. Reexamination 10/549,300 BANNEN ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 /Venkataraman 1624 **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY \* 07-1998 514/253.12 US-5,780,472 Cho et al. Α US-В US-С US-D US-Ε US-F US-G US-Н US-US-J US-Κ US-L US-Μ FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W Χ

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